74HC154; 74HCT154 4-to-16 line decoder/demultiplexer Rev. 06 — 12 February 2007

Product data sheet

1. **General description**

The 74HC154; 74HCT154 is a high-speed Si-gate CMOS device and is pin compatible with Low-power Schottky TTL (LSTTL).

The 74HC154; 74HCT154 decoders accept four active HIGH binary address inputs and provide 16 mutually-exclusive active LOW outputs. The two-input enable gate can be used to strobe the decoder to eliminate the normal decoding 'glitches' on the outputs, or can be used for the expansion of the decoder.

The enable gate has two ANDed inputs which must be LOW to enable the outputs.

The 74HC154; 74HCT154 can be used as a 1-to-16 demultiplexer by using one of the enable inputs as the multiplexed data input.

When the other enable input is LOW, the addressed output will follow the state of the applied data.

2. **Features**

- 16-line demultiplexing capability
- Decodes 4 binary-coded inputs into 16 mutually-exclusive outputs
- Complies with JEDEC standard no. 7A
- Specified from -40 °C to +85 °C and -40 °C to +125 °C
- ESD protection:
 - HBM EIA/JESD22-A114D exceeds 2000 V
 - MM EIA/JESD22-A115-A exceeds 200 V

3. **Ordering information**

Table 1. **Ordering information**

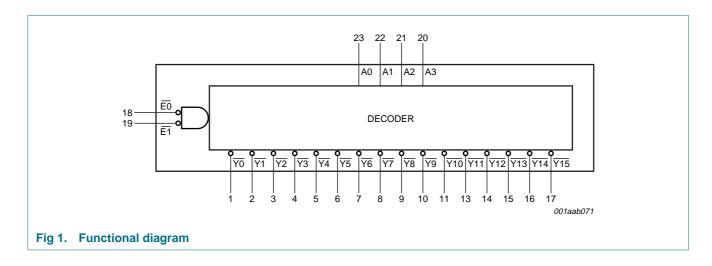
Type number	Package								
	Temperature range	Name	Description	Version					
74HC154									
74HC154N	–40 °C to +125 °C	DIP24	plastic dual in-line package; 24 leads (600 mil)	SOT101-1					
74HC154D	–40 °C to +125 °C	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1					
74HC154DB	–40 °C to +125 °C	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1					
74HC154PW	–40 °C to +125 °C	TSSOP24	plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1					

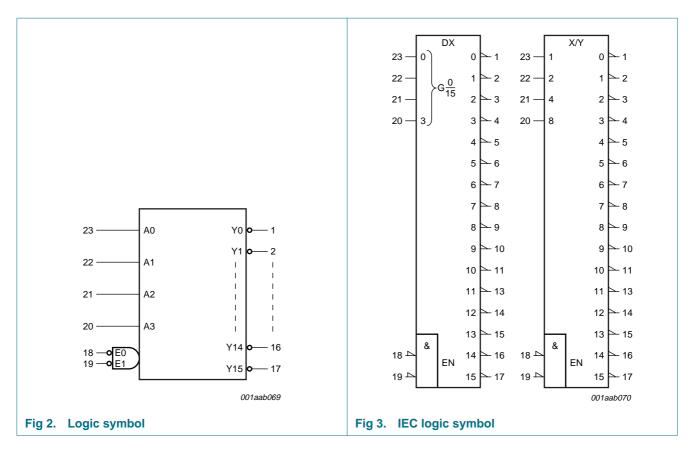


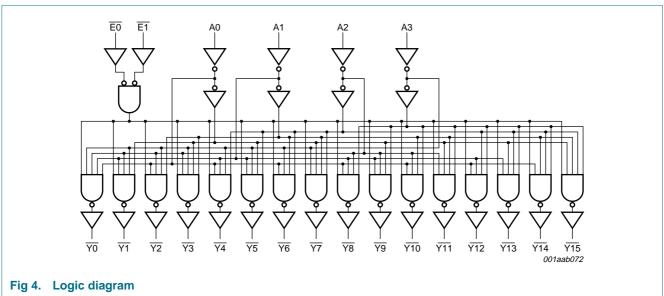
 Table 1.
 Ordering information ...continued

Type number	Package			
	Temperature range	Name	Description	Version
74HC154BQ	–40 °C to +125 °C	DHVQFN24	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 24 terminals; body $3.5\times5.5\times0.85$ mm	SOT815-1
74HCT154				
74HCT154N	–40 °C to +125 °C	DIP24	plastic dual in-line package; 24 leads (600 mil)	SOT101-1
74HCT154D	–40 °C to +125 °C	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1
74HCT154DB	–40 °C to +125 °C	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1
74HCT154PW	–40 °C to +125 °C	TSSOP24	plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1
74HCT154BQ	–40 °C to +125 °C	DHVQFN24	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 24 terminals; body $3.5\times5.5\times0.85~\text{mm}$	SOT815-1

4. Functional diagram

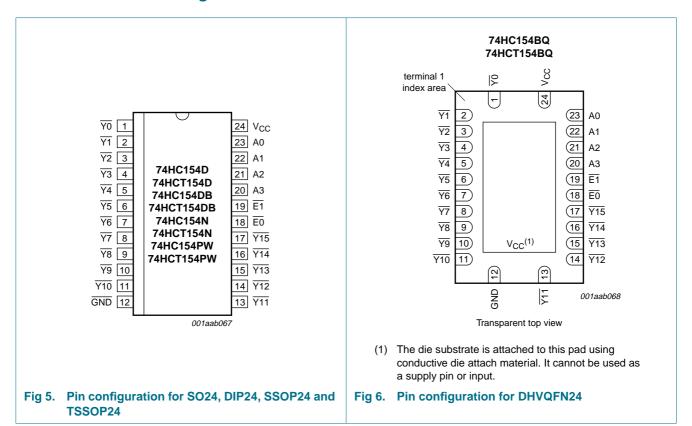






5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
<u>Y0</u>	1	data output (active LOW)
<u>Y1</u>	2	data output (active LOW)
Y 2	3	data output (active LOW)
Y 3	4	data output (active LOW)
<u>Y4</u>	5	data output (active LOW)
<u>Y5</u>	6	data output (active LOW)
<u>Y6</u>	7	data output (active LOW)
Y7	8	data output (active LOW)
Y 8	9	data output (active LOW)
Y 9	10	data output (active LOW)
<u>Y10</u>	11	data output (active LOW)
GND	12	ground (0 V)
<u>Y11</u>	13	data output (active LOW)
<u>Y12</u>	14	data output (active LOW)

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 Table 2.
 Pin description ...continued

Symbol	Pin	Description
<u>Y13</u>	15	data output (active LOW)
<u>Y14</u>	16	data output (active LOW)
Y15	17	data output (active LOW)
E0	18	enable input (active LOW)
E1	19	enable input (active LOW)
A3	20	address input
A2	21	address input
A1	22	address input
A0	23	address input
V _{CC}	24	supply voltage

6. Functional description

Table 3. Function table[1]

Inp	ut					Out	tput														
E0	E1	A0	A1	A2	А3	<u>Y0</u>	<u>Y1</u>	<u>Y2</u>	<u></u> 73	<u>¥4</u>	Y5	Y6	Y7	Y8	<u>79</u>	<u>Y10</u>	<u>Y11</u>	<u>Y12</u>	<u>Y13</u>	Y14	<u>Y15</u>
Н	Н	Χ	Χ	Χ	Χ	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
Н	L	Χ	Χ	Χ	Χ	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
L	Н	Χ	Χ	Χ	Χ	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
L	L	L	L	L	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
		Н	L	L	L	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
		L	Н	L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
		Н	Н	L	L	Н	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
		L	L	Н	L	Н	Н	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
		Н	L	Н	L	Н	Н	Н	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
		L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н
		Н	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н
		L	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н	Н	Н	Н	Н	Н	Н
		Н	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н	Н	Н	Н	Н	Н
		L	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н	Н	Н	Н	Н
		Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н	Н	Н	Н
		L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н	Н	Н
		Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н	Н
		L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н
		Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L

^[1] H = HIGH voltage level

L = LOW voltage level

X = don't care.

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+7.0	V
I _{IK}	input clamping current	$V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$	<u>[1]</u> -	±20	mA
l _{OK}	output clamping current	V_O < -0.5 V or V_O > V_{CC} + 0.5 V	<u>[1]</u> -	±20	mA
lo	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	<u>[1]</u> -	±25	mA
I _{CC}	supply current		<u>[1]</u> -	50	mA
I _{GND}	ground current		<u>[1]</u> -	-50	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$	[2] _	300	mW

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

For SO24 packages: Ptot derates linearly at 8 mW/K above 70 °C.

For SSOP24 and TSSOP24 packages: Ptot derates linearly at 5.5 mW/K above 60 °C.

For DHVQFN24 packages: Ptot derates linearly at 4.5 mW/K above 60 °C.

8. Recommended operating conditions

Table 5. Operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
74HC154						
V_{CC}	supply voltage		2.0	5.0	6.0	V
V_{I}	input voltage		0	-	V_{CC}	V
V_{O}	output voltage		0	-	V_{CC}	V
T _{amb}	ambient temperature		-40	+25	+125	°C
t _r	rise time	$V_{CC} = 2.0 \text{ V}$	-	-	1000	ns
		V _{CC} = 4.5 V	-	6.0	500	ns
		$V_{CC} = 6.0 \text{ V}$	-	-	400	ns
t _f	fall time	$V_{CC} = 2.0 \text{ V}$	-	-	1000	ns
		$V_{CC} = 4.5 \text{ V}$	-	6.0	500	ns
		$V_{CC} = 6.0 \text{ V}$	-	-	400	ns
74HCT154						
V_{CC}	supply voltage		4.5	5.0	5.5	V
V_{I}	input voltage		0	-	V_{CC}	V
Vo	output voltage		0	-	V_{CC}	V
T _{amb}	ambient temperature		-40	+25	+125	°C
t _r	input rise time	$V_{CC} = 4.5 \text{ V}$	-	6.0	500	ns
t _f	input fall time	$V_{CC} = 4.5 \text{ V}$	-	6.0	500	ns

^[2] For DIP24 packages: Ptot derates linearly at 12 mW/K above 70 °C.

9. Static characteristics

Table 6. Static characteristics 74HC154

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T _{amb} = 25	°C					
V _{IH}	HIGH-level input voltage	V _{CC} = 2.0 V	1.5	1.2	-	V
		V _{CC} = 4.5 V	3.15	2.4	-	V
		V _{CC} = 6.0 V	4.2	3.2	-	V
V _{IL}	LOW-level input voltage	V _{CC} = 2.0 V	-	0.8	0.5	V
		V _{CC} = 4.5 V	-	2.1	1.35	V
		V _{CC} = 6.0 V	-	2.8	1.8	V
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 2.0 \text{ V}; I_{O} = -20 \mu\text{A}$	1.9	2.0	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -20 \mu\text{A}$	4.4	4.5	-	V
		$V_{CC} = 6.0 \text{ V; } I_{O} = -20 \mu\text{A}$	5.9	6.0	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -4.0 \text{ mA}$	3.98	4.32	-	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = -5.2 \text{ mA}$	5.48	5.81	-	V
V _{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL}	$\begin{array}{cccccccccccccccccccccccccccccccccccc$			
		$V_{CC} = 2.0 \text{ V}; I_{O} = 20 \mu\text{A}$	-	0	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 20 \mu\text{A}$	-	0	0.1	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = 20 \mu\text{A}$	-	0	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 4.0 \text{ mA}$	-	0.15	0.26	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = 5.2 \text{ mA}$	-	0.16	0.26	V
l _l	input leakage current	$V_{CC} = 6.0 \text{ V}; V_I = V_{CC} \text{ or GND}$	-	-	±0.1	μΑ
I _{cc}	supply current	$V_{CC} = 6.0 \text{ V}$; $V_I = V_{CC} \text{ or GND}$; $I_O = 0 \text{ A}$	-	-	8.0	μΑ
Cı	input capacitance		-	3.5	-	pF
T _{amb} = -40) °C to +85 °C					
V _{IH}	HIGH-level input voltage	V _{CC} = 2.0 V	1.5	-	-	V
		V _{CC} = 4.5 V	3.15	-	-	V
		V _{CC} = 6.0 V	4.2	-	-	V
V _{IL}	LOW-level input voltage	V _{CC} = 2.0 V	-	-	0.5	V
		V _{CC} = 4.5 V	-	-	1.35	V
		V _{CC} = 6.0 V	-	-	1.8	V
V _{OH}	HIGH-level output voltage	$V_{I} = V_{IH}$ or V_{IL}				
		$V_{CC} = 2.0 \text{ V}; I_{O} = -20 \mu\text{A}$	1.9	-	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -20 \mu\text{A}$	4.4	-	-	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = -20 \mu\text{A}$	5.9	-	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -4.0 \text{ mA}$	3.84	-	-	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = -5.2 \text{ mA}$	5.34	-	-	V

 Table 6.
 Static characteristics 74HC154 ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 2.0 \text{ V}; I_{O} = 20 \mu\text{A}$	-	-	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 20 \mu\text{A}$	-	-	0.1	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = 20 \mu\text{A}$	-	-	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 4.0 \text{ mA}$	-	-	0.33	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = 5.2 \text{ mA}$	-	-	0.33	V
l _l	input leakage current	$V_{CC} = 6.0 \text{ V}; V_I = V_{CC} \text{ or GND}$	-	-	±1.0	μΑ
I _{CC}	supply current	$V_{CC} = 6.0 \text{ V}$; $V_I = V_{CC} \text{ or GND}$; $I_O = 0 \text{ A}$	-	-	80	μΑ
T _{amb} = -40	°C to +125 °C					
V _{IH}	HIGH-level input voltage	V _{CC} = 2.0 V	1.5	-	-	V
		V _{CC} = 4.5 V	3.15	-	-	V
		V _{CC} = 6.0 V	4.2	-	-	V
V _{IL}	LOW-level input voltage	V _{CC} = 2.0 V	-	-	0.5	V
		V _{CC} = 4.5 V	-	-	1.35	V
		V _{CC} = 6.0 V	-	-	1.8	V
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 2.0 \text{ V}; I_{O} = -20 \mu\text{A}$	1.9	-	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -20 \mu\text{A}$	4.4	-	-	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = -20 \mu\text{A}$	5.9	-	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -4.0 \text{ mA}$	3.7	-	-	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = -5.2 \text{ mA}$	5.2	-	-	V
V _{OL}	LOW-level output voltage	$V_I = V_{IH} \text{ or } V_{IL}$				
		$V_{CC} = 2.0 \text{ V}; I_{O} = 20 \mu\text{A}$	-	-	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 20 \mu\text{A}$	-	-	0.1	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = 20 \mu\text{A}$	-	-	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 4.0 \text{ mA}$	-	-	0.4	V
		$V_{CC} = 6.0 \text{ V}; I_{O} = 5.2 \text{ mA}$	-	-	0.4	V
l _l	input leakage current	$V_{CC} = 6.0 \text{ V}; V_I = V_{CC} \text{ or GND}$	-	-	±0.1	μΑ
I _{CC}	supply current	$V_{CC} = 6.0 \text{ V}; V_{I} = V_{CC} \text{ or GND}; I_{O} = 0 \text{ A}$	-	-	160	μΑ

Table 7. Static characteristics 74HCT154

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T _{amb} = 25 °C	C					
V_{IH}	HIGH-level input voltage	V _{CC} = 4.5 V to 5.5 V	2.0	1.6	-	V
V_{IL}	LOW-level input voltage	V _{CC} = 4.5 V to 5.5 V	-	1.2	8.0	V
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 4.5 \text{ V}; I_{O} = -20 \mu\text{A}$	4.4	4.5	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -4 \text{ mA}$	3.98	4.32	-	V

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 Table 7.
 Static characteristics 74HCT154 ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 4.5 \text{ V}; I_{O} = 20 \mu\text{A}$	-	0	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 4 \text{ mA}$	-	0.15	0.25	V
I _I	input leakage current	$V_{CC} = 5.5 \text{ V}; V_I = V_{CC} \text{ or GND}$	-	-	±0.1	μΑ
I _{CC}	supply current	$V_{CC} = 5.5 \text{ V}; V_I = V_{CC} \text{ or GND}; I_O = 0 \text{ A}$	-	-	8.0	μΑ
ΔI_{CC}	additional supply current	per input pin; $V_{CC} = 4.5 \text{ V}$ to 5.5 V; $V_I = V_{CC} - 2.1 \text{ V}$; $I_O = 0 \text{ A}$	-	-	360	μΑ
Cı	input capacitance		-	3.5	-	pF
T _{amb} = -40	°C to +85 °C					
V_{IH}	HIGH-level input voltage	V _{CC} = 4.5 V to 5.5 V	2.0	-	-	V
V_{IL}	LOW-level input voltage	V _{CC} = 4.5 V to 5.5 V	-	-	8.0	V
V_{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 4.5 \text{ V}; I_{O} = -20 \mu\text{A}$	4.4	-	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -4 \text{ mA}$	3.84	-	-	V
V _{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 4.5 \text{ V}; I_{O} = 20 \mu\text{A}$	-	-	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 4 \text{ mA}$	-	-	0.33	V
I _I	input leakage current	$V_{CC} = 5.5 \text{ V}; V_I = V_{CC} \text{ or GND}$	-	-	±1.0	μΑ
I _{CC}	supply current	$V_{CC} = 5.5 \text{ V}$; $V_I = V_{CC} \text{ or GND}$; $I_O = 0 \text{ A}$	-	-	80	μΑ
ΔI_{CC}	additional supply current	per input pin; V_{CC} = 4.5 V to 5.5 V; $V_I = V_{CC} - 2.1$ V; $I_O = 0$ A	-	-	450	μΑ
$T_{amb} = -40$	°C to +125 °C					
V _{IH}	HIGH-level input voltage	V _{CC} = 4.5 V to 5.5 V	2.0	-	-	V
V _{IL}	LOW-level input voltage	V _{CC} = 4.5 V to 5.5 V	-	-	8.0	V
V_{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 4.5 \text{ V}; I_{O} = -20 \mu\text{A}$	4.4	-	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -4 \text{ mA}$	3.7	-	-	V
V_{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$V_{CC} = 4.5 \text{ V}; I_{O} = 20 \mu\text{A}$	-	-	0.1	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 4 \text{ mA}$	-	-	0.4	V
I _I	input leakage current	$V_{CC} = 5.5 \text{ V}; V_I = V_{CC} \text{ or GND}$	-	-	±1.0	μΑ
I _{CC}	supply current	V_{CC} = 5.5 V; V_I = V_{CC} or GND; I_O = 0 A	-	-	160	μΑ
ΔI_{CC}	additional supply current	per input pin; $V_{CC} = 4.5 \text{ V}$ to 5.5 V; $V_I = V_{CC} - 2.1 \text{ V}$; $I_O = 0 \text{ A}$	-	-	490	μΑ

10. Dynamic characteristics

Table 8. Dynamic characteristics

GND (ground = 0 V); C_L = 50 pF unless otherwise specified; for test circuit, see Figure 9.

Symbol	Parameter	Conditions			25 °C		-4	0 °C to +1	25 °C	Unit
				Min	Тур	Max	Min	Max (85 °C)	Max (125 °C)	
74HC154										
t _{pd}	propagation delay	An to Yn; see Figure 7	<u>[1]</u>							
		$V_{CC} = 2.0 \text{ V}$		-	36	150	-	190	225	ns
		$V_{CC} = 4.5 V$		-	13	30	-	38	45	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	11	-	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}$		-	10	26	-	33	38	ns
		En to Yn; see Figure 8								
		$V_{CC} = 2.0 \text{ V}$		-	39	150	-	190	225	ns
		$V_{CC} = 4.5 V$		-	14	30	-	38	45	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	11	-	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}$		-	11	26	-	33	38	ns
t _t	transition time	see Figure 7 and 8	[2]							
		$V_{CC} = 2.0 \text{ V}$		-	19	75	-	95	110	ns
		$V_{CC} = 4.5 V$		-	7	15	-	19	22	ns
		$V_{CC} = 6.0 \text{ V}$		-	6	13	-	16	19	ns
C_{PD}	power dissipation capacitance	per gate; $V_I = GND$ to V_{CC}	[3]	-	60	-	-	-	-	pF
74HCT15	4									
t _{pd}	propagation delay	An to Yn; see Figure 7	<u>[1]</u>							
		$V_{CC} = 4.5 V$		-	16	35	-	44	53	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	13	-	-	-	-	ns
		En to Yn; see Figure 8								
		$V_{CC} = 4.5 V$		-	15	32	-	40	48	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	13	-	-	-	-	ns
t _t	transition time	see Figure 7 and 8	[2]							
		$V_{CC} = 4.5 \text{ V}$		-	7	15	-	19	22	ns
C_{PD}	power dissipation capacitance	per gate; $V_1 = GND$ to $(V_{CC} - 1.5 V)$	[3]	-	60	-	-	-	-	pF

^[1] t_{pd} is the same as t_{PLH} and t_{PHL}

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o)$ where:

 f_i = input frequency in MHz;

 f_o = output frequency in MHz;

C_L = output load capacitance in pF;

 V_{CC} = supply voltage in V;

N = number of load switching outputs;

 $\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs.

^[2] t_t is the same as t_{TLH} and t_{THL}

^[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

11. Waveforms

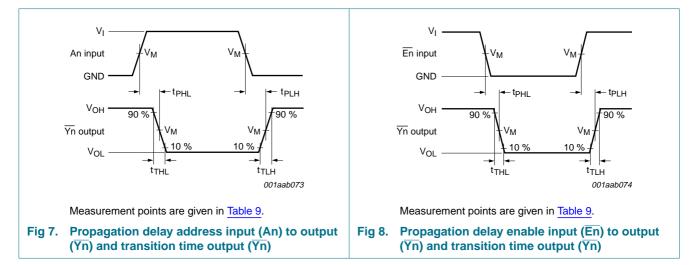
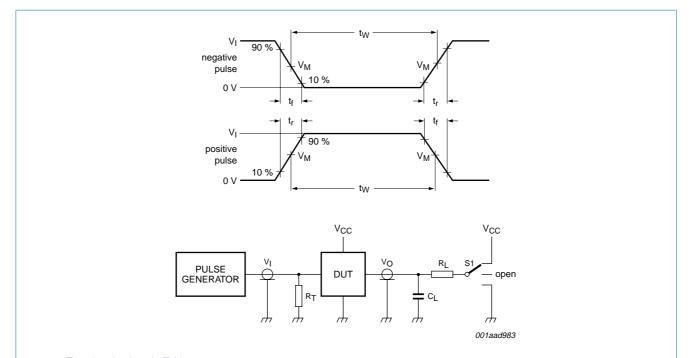


Table 9. Measurement points

Туре	Input	Output
	V _M	V _M
74HC154	0.5V _{CC}	0.5V _{CC}
74HCT154	1.3 V	1.3 V



Test data is given in Table 10.

Definitions for test circuit:

 R_T = Termination resistance; should be equal to output impedance Z_0 of the pulse generator.

C_L = Load capacitance including jig and probe capacitance.

R_L = Load resistor.

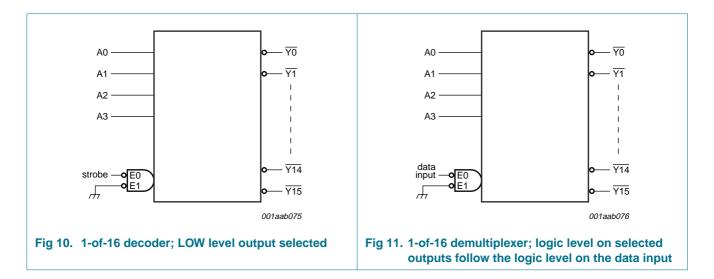
S1 = Test selection switch.

Fig 9. Load circuitry for measuring switching times

Table 10. Test data

Туре	Input		Load		S1 position		
	VI	t _r , t _f	CL	R_L	t _{PHL} , t _{PLH}		
74HC154	V_{CC}	6 ns	15 pF, 50 pF	1 kΩ	open		
74HCT154	3 V	6 ns	15 pF, 50 pF	1 kΩ	open		

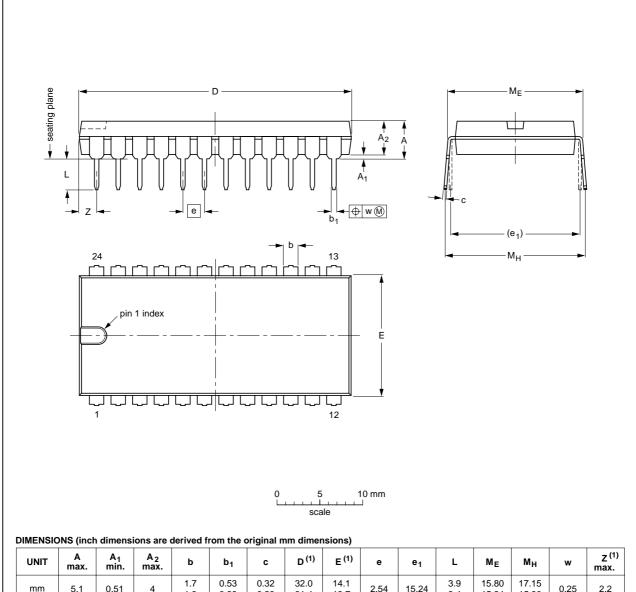
12. Application information



13. Package outline

DIP24: plastic dual in-line package; 24 leads (600 mil)

SOT101-1



UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	С	D ⁽¹⁾	E ⁽¹⁾	е	e ₁	L	ME	Мн	w	Z ⁽¹⁾ max.
mm	5.1	0.51	4	1.7 1.3	0.53 0.38	0.32 0.23	32.0 31.4	14.1 13.7	2.54	15.24	3.9 3.4	15.80 15.24	17.15 15.90	0.25	2.2
inches	0.2	0.02	0.16	0.066 0.051	0.021 0.015	0.013 0.009	1.26 1.24	0.56 0.54	0.1	0.6	0.15 0.13	0.62 0.60	0.68 0.63	0.01	0.087

Note

1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

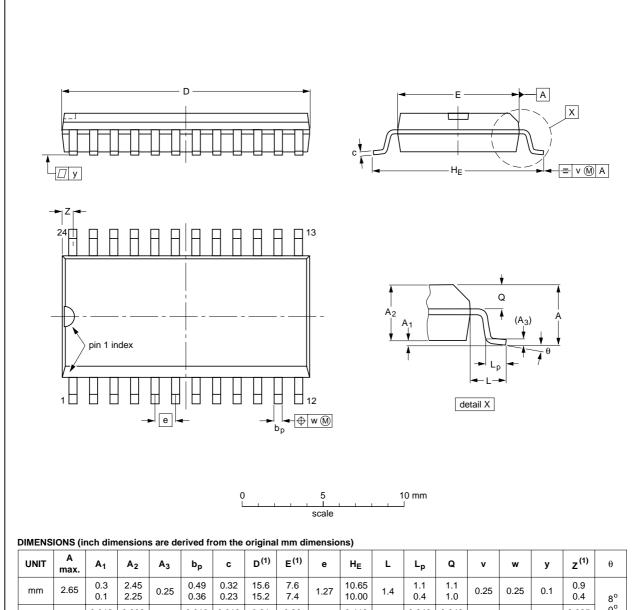
OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT101-1	051G02	MO-015	SC-509-24		99-12-27 03-02-13

Fig 12. Package outline SOT101-1 (DIP24)

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SO24: plastic small outline package; 24 leads; body width 7.5 mm

SOT137-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	z ⁽¹⁾	θ
mm	2.65	0.3 0.1	2.45 2.25	0.25	0.49 0.36	0.32 0.23	15.6 15.2	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8°
inches	0.1	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.61 0.60	0.30 0.29	0.05	0.419 0.394	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	0°

Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

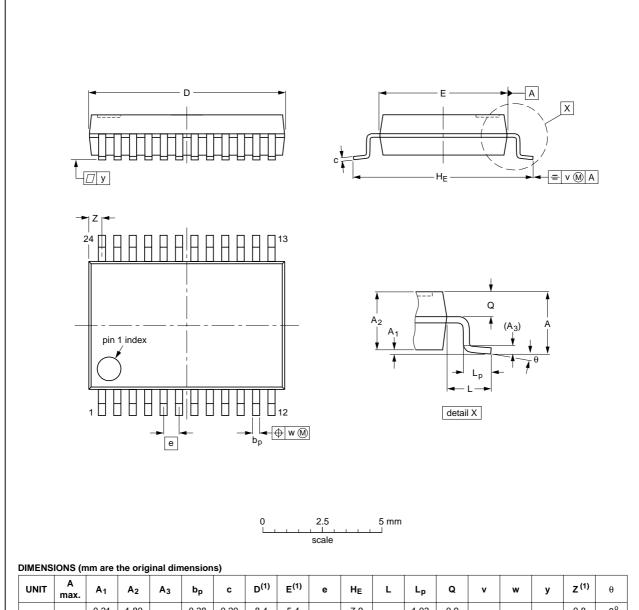
OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT137-1	075E05	MS-013			-99-12-27 03-02-19

Fig 13. Package outline SOT137-1 (SO24)

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SSOP24: plastic shrink small outline package; 24 leads; body width 5.3 mm

SOT340-1



UNIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	8.4 8.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	0.8 0.4	8° 0°

Note

1. Plastic or metal protrusions of 0.2 mm maximum per side are not included.

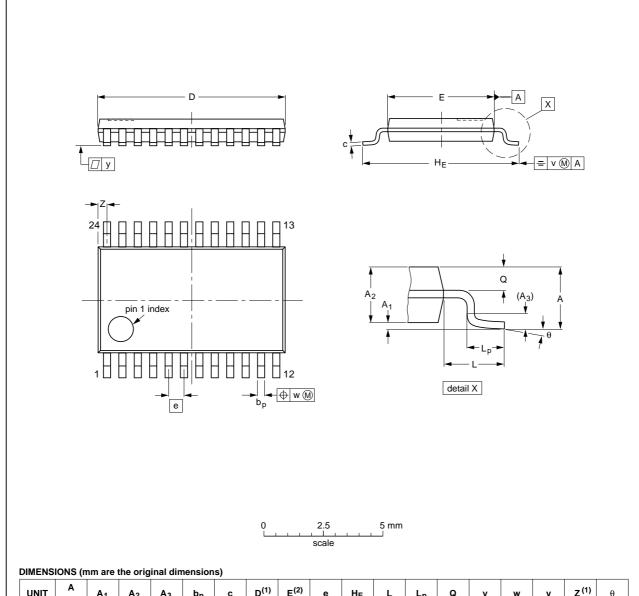
OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT340-1		MO-150			99-12-27 03-02-19

Fig 14. Package outline SOT340-1 (SSOP24)

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TSSOP24: plastic thin shrink small outline package; 24 leads; body width 4.4 mm

SOT355-1



 						-,												
UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	7.9 7.7	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT355-1		MO-153			99-12-27 03-02-19
301333-1		IVIO-153			03

Fig 15. Package outline SOT355-1 (TSSOP24)

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DHVQFN24: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 24 terminals; body $3.5 \times 5.5 \times 0.85$ mm

SOT815-1

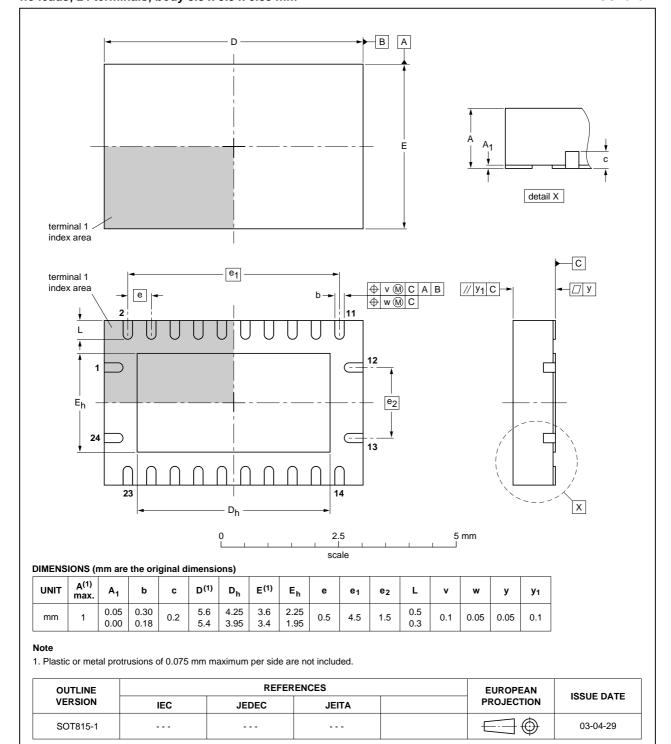


Fig 16. Package outline SOT815-1 (DHVQFN24)

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14. Abbreviations

Table 11. Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
LSTTL	Low-power Schottky Transistor-Transistor Logic
MM	Machine Model

15. Revision history

Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT154_6	20070212	Product data sheet	-	74HC_HCT154_5
Modifications:		t of this data sheet has been of NXP Semiconductors.	redesigned to comply v	with the new identity
	 Legal texts 	have been adapted to the n	ew company name whe	ere appropriate.
	• Table 3 on	page 5: Corrected errors in	output information.	
74HC_HCT154_5	20041012	Product specification	-	74HC_HCT154_4
74HC_HCT154_4	20041005	Product specification	-	74HC_HCT154_3
74HC_HCT154_3	20040601	Product specification	-	74HC_HCT154_CNV_2

16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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